

NTLLD4901NF

Dual N-Channel Power MOSFET with Integrated Schottky

30 V, High Side 11 A / Low Side 13 A,
Dual N-Channel, WDFN (3 mm x 3 mm)

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Low Side MOSFET with Integrated Schottky
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

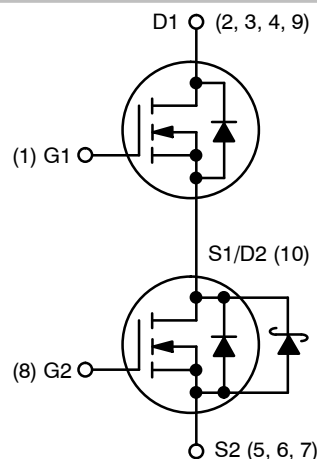
- DC-DC Converters
- System Voltage Rails
- Point of Load



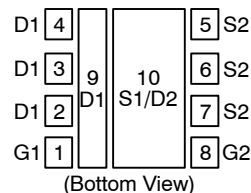
ON Semiconductor®

<http://onsemi.com>

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ MAX}$	$I_D \text{ MAX}$
Q1 Top FET 30 V	17.4 m Ω @ 10 V	11 A
	25 m Ω @ 4.5 V	
Q2 Bottom FET 30 V	13.3 m Ω @ 10 V	13 A
	20 m Ω @ 4.5 V	



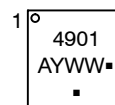
PIN CONNECTIONS



MARKING DIAGRAM



WDFN8
CASE 511BP



4901 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

NTLLD4901NF

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage		Q1	V _{DSS}	30	V	
Drain-to-Source Voltage		Q2				
Gate-to-Source Voltage		Q1	V _{GS}	±20	V	
Gate-to-Source Voltage		Q2				
Continuous Drain Current R _{θJA} (Note 1)	Steady State	T _A = 25°C	I _D	8.3	A	
		T _A = 85°C		6.0		
		T _A = 25°C		9.6		
		T _A = 85°C		6.9		
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	Q1	P _D	1.82	W
			Q2		1.88	
Continuous Drain Current R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C	Q1	I _D	11	A
		T _A = 85°C			8	
		T _A = 25°C	Q2		13	
		T _A = 85°C			9.1	
Power Dissipation R _{θJA} ≤ 10 s (Note 1)		T _A = 25°C	Q1	P _D	3.23	W
			Q2		3.27	
Continuous Drain Current R _{θJA} (Note 2)		T _A = 25°C	Q1	I _D	5.5	A
		T _A = 85°C			4.0	
		T _A = 25°C	Q2		6.3	
		T _A = 85°C			4.5	
Power Dissipation R _{θJA} (Note 2)		T _A = 25 °C	Q1	P _D	0.80	W
			Q2		0.81	
Pulsed Drain Current		TA = 25°C tp = 10 μs	I _{DM}	65	A	
				70		
Operating Junction and Storage Temperature		Q1	T _J , T _{STG}	–55 to +150	°C	
		Q2				
Source Current (Body Diode)		Q1	I _S	4.2	A	
		Q2		6.0		
Drain to Source DV/DT			dV/dt	6	V/ns	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25C, V _{DD} = 50 V, V _{GS} = 10 V, I _L = 9.0 A _{pk} , L = 0.3 mH, R _G = 25 Ω)		Q1	EAS	12	mJ	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25C, V _{DD} = 50 V, V _{GS} = 10 V, I _L = 9.5 A _{pk} , L = 0.3 mH, R _G = 25 Ω)		Q2	EAS	13.5		
Lead Temperature for Soldering Purposes (1/8” from case for 10 s)			T _L	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu
2. Surface-mounted on FR4 board using the minimum recommended pad size of 90 mm²

NTLLD4901NF

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	FET	Symbol	Value	Unit
Junction-to-Ambient – Steady State (Note 3)	Q1	$R_{\theta JA}$	68.8	°C/W
	Q2		66.4	
Junction-to-Ambient – Steady State (Note 4)	Q1	$R_{\theta JA}$	156.4	
	Q2		153.9	
Junction-to-Ambient – ($t \leq 10$ s) (Note 3)	Q1	$R_{\theta JA}$	38.7	
	Q2		38.2	

3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu

4. Surface-mounted on FR4 board using the minimum recommended pad size of 90 mm²

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Break-down Voltage	Q1	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	30			V
	Q2			30			
Drain-to-Source Break-down Voltage Temperature Coefficient	Q1	$V_{(BR)DSS} / T_J$			18		mV / °C
	Q2				15		
Zero Gate Voltage Drain Current	Q1	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$	$T_J = 25^\circ\text{C}$		1	μA
				$T_J = 125^\circ\text{C}$		10	
	Q2	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$	$T_J = 25^\circ\text{C}$		500	
				$T_J = 125^\circ\text{C}$		500	
Gate-to-Source Leakage Current	Q1	I_{GSS}	$V_{GS} = 0\text{ V}, V_{DS} = \pm 20\text{ V}$			± 100	nA
	Q2					± 100	

ON CHARACTERISTICS (Note 5)

Gate Threshold Voltage	Q1	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$		1.2		2.2	V
	Q2				1.2		2.2	
Negative Threshold Temperature Coefficient	Q1	$V_{GS(TH)} / T_J$				4.5		mV / °C
	Q2					4.0		
Drain-to-Source On Resistance	Q1	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$	$I_D = 9\text{ A}$		14	17.4	mΩ
			$V_{GS} = 4.5\text{ V}$	$I_D = 9\text{ A}$		20	25	
	Q2		$V_{GS} = 10\text{ V}$	$I_D = 11\text{ A}$		11	13.3	
			$V_{GS} = 4.5\text{ V}$	$I_D = 11\text{ A}$		16	20	
Forward Transconductance	Q1	g_{FS}	$V_{DS} = 1.5\text{ V}, I_D = 9\text{ A}$			16		S
	Q2					18		

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	Q1	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V		605		pF
	Q2				660		
Output Capacitance	Q1	C _{OSS}			190		
	Q2				325		
Reverse Capacitance	Q1	C _{RSS}			102		
	Q2				17.5		

5. Pulse Test: pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$

6. Switching characteristics are independent of operating junction temperatures.

NTLLD4901NF

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit
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CHARGES, CAPACITANCES & GATE RESISTANCE

Total Gate Charge	Q1	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 9 A		6.5		nC
	Q2				5.0		
Threshold Gate Charge	Q1	Q _{G(TH)}			1.1		
	Q2				1.1		
Gate-to-Source Charge	Q1	Q _{GS}			1.9		
	Q2				2.0		
Gate-to-Drain Charge	Q1	Q _{GD}			3.2		
	Q2				1.46		
Total Gate Charge	Q1	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 9 A		12		nC
	Q2				10.6		

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	Q1	$t_{d(ON)}$	$V_{GS} = 4.5\text{ V}, V_{DS} = 15\text{ V},$ $I_D = 9\text{ A}, R_G = 3.0\text{ }\Omega$		8.0		ns
	Q2				7.5		
Rise Time	Q1	t_r			7.2		
	Q2				11.2		
Turn-Off Delay Time	Q1	$t_{d(OFF)}$			11		
	Q2				11.6		
Fall Time	Q1	t_f			3.3		
	Q2				1.9		

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	Q1	$t_{d(ON)}$	$V_{GS} = 10\text{ V}, V_{DS} = 15\text{ V},$ $I_D = 9\text{ A}, R_G = 3.0\ \Omega$		4.2		ns
	Q2				4.3		
Rise Time	Q1	t_r			11.6		
	Q2				11.4		
Turn-Off Delay Time	Q1	$t_{d(OFF)}$			14.1		
	Q2				14.3		
Fall Time	Q1	t_f			2.0		
	Q2				1.3		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Voltage	Q1	VSD	VGS = 0 V, IS = 3 A	TJ = 25°C		0.80	1.2	V
				TJ = 125°C		0.65		
	Q2		VGS = 0 V, IS = 2 A	TJ = 25°C		0.50	0.80	
				TJ = 125°C		0.45		

5. Pulse Test: pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$

6. Switching characteristics are independent of operating junction temperatures.

NTLLD4901NF

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Typ	Max	Unit
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DRAIN-SOURCE DIODE CHARACTERISTICS

Reverse Recovery Time	Q1	t_{RR}	$V_{GS} = 0\text{ V}, dI_S/dt = 100\text{ A}/\mu\text{s}, I_S = 3\text{ A}$		17.9		ns
	Q2				23.3		
Charge Time	Q1	t_a			9.0		
	Q2				11.3		
Discharge Time	Q1	t_b			9.0		
	Q2				12		
Reverse Recovery Charge	Q1	Q_{RR}			8.0		nC
	Q2				12		

PACKAGE PARASITIC VALUES

Source Inductance	Q1	L _S	T _A = 25°C		0.36		nH
	Q2				0.36		
Drain Inductance	Q1	L _D			0.054		nH
	Q2				0.054		
Gate Inductance	Q1	L _G			1.3		nH
	Q2				1.3		
Gate Resistance	Q1	R _G			0.8		Ω
	Q2				0.8		

5. Pulse Test: pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$

6. Switching characteristics are independent of operating junction temperatures.

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLLD4901NFTWG	WDFN8 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS – Q1

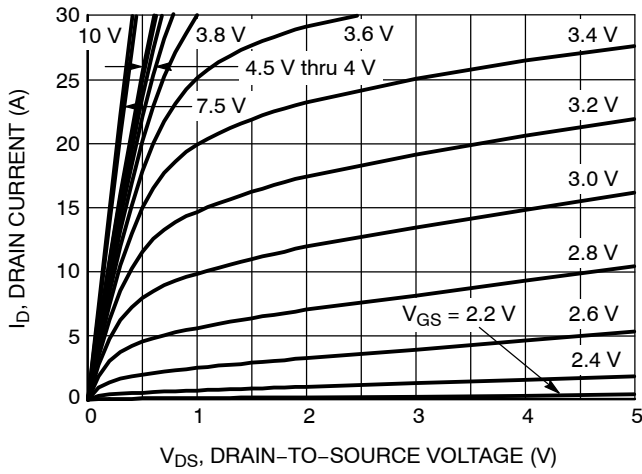


Figure 1. On-Region Characteristics

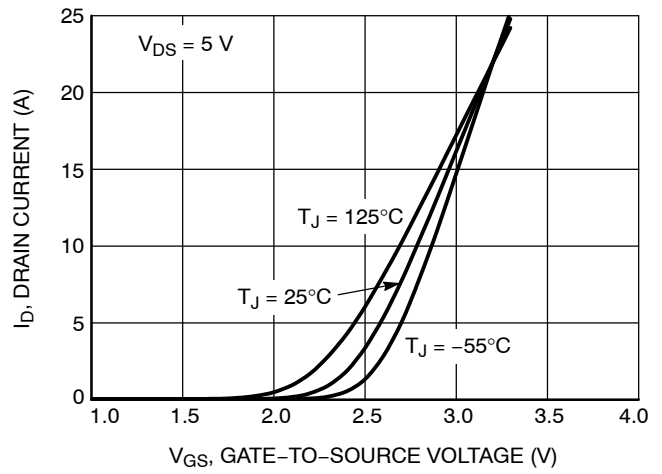


Figure 2. Transfer Characteristics

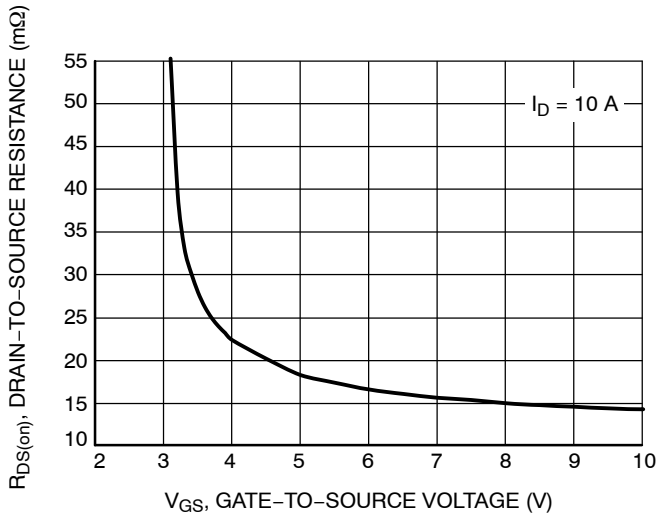


Figure 3. On-Resistance vs. Gate-to-Source Resistance

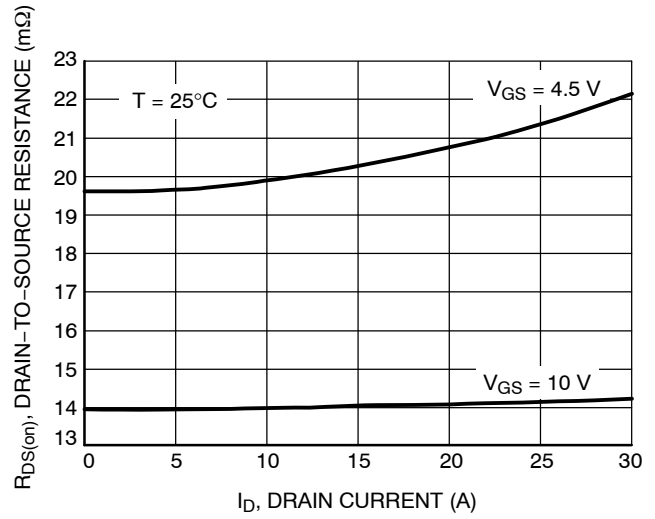


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

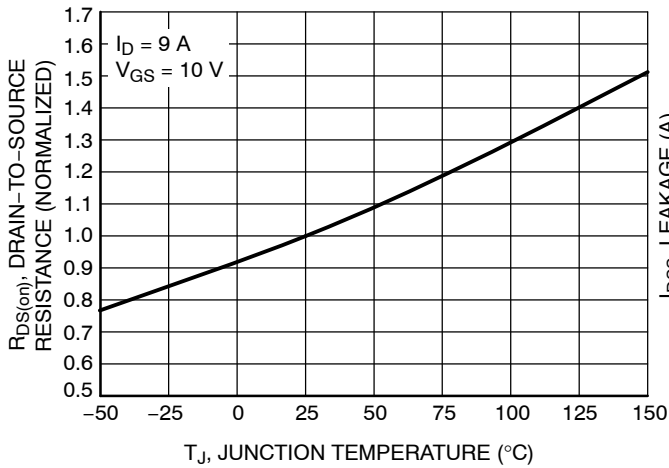


Figure 5. On-Resistance Variation with Temperature

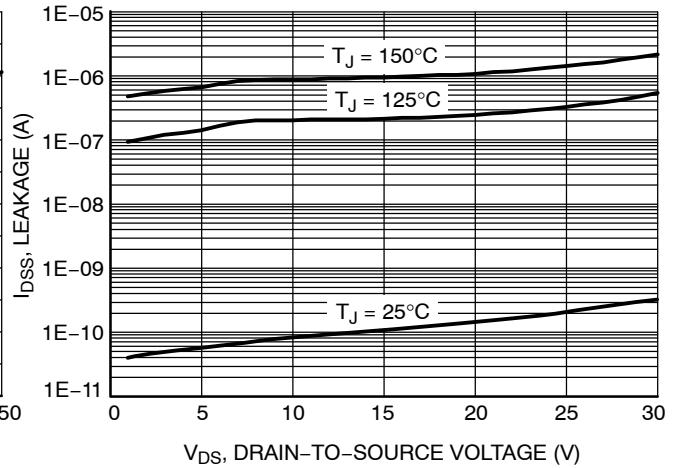


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS – Q1

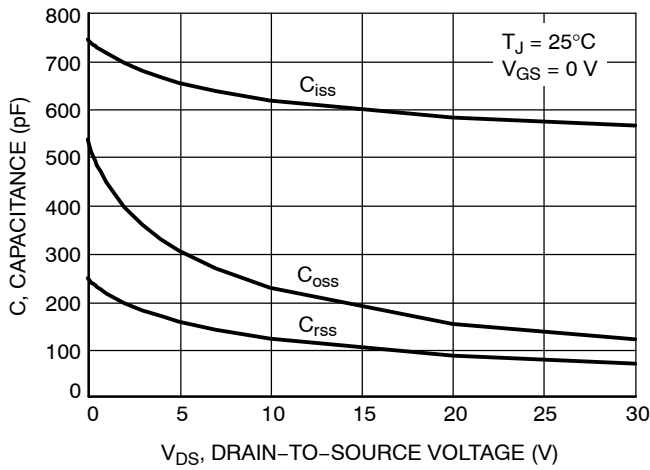


Figure 7. Capacitance Variation

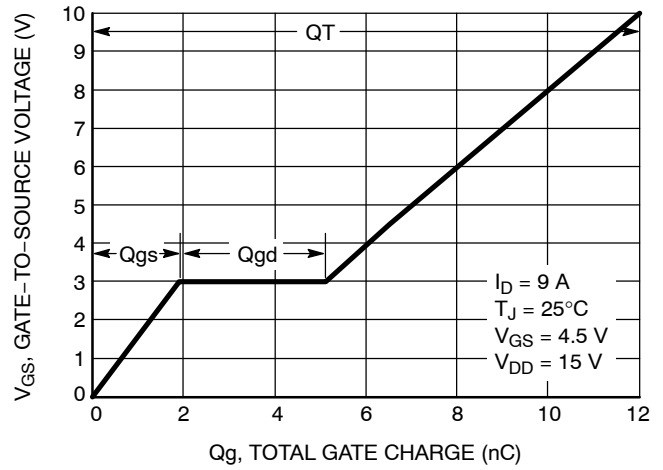


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

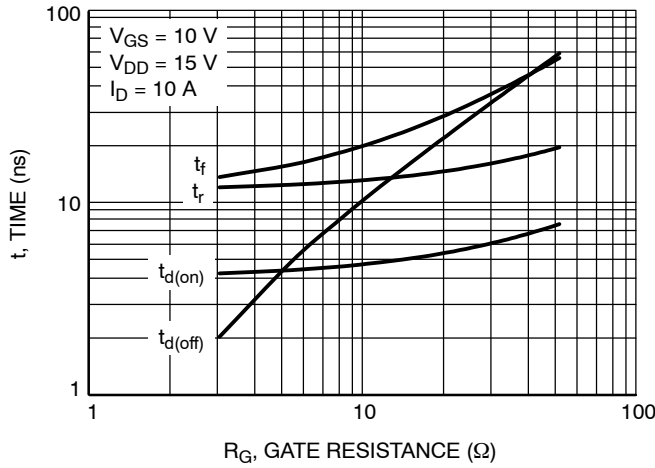


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

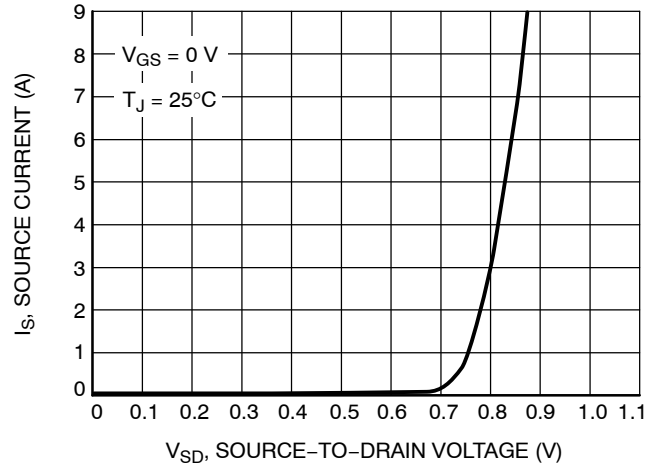


Figure 10. Diode Forward Voltage vs. Current

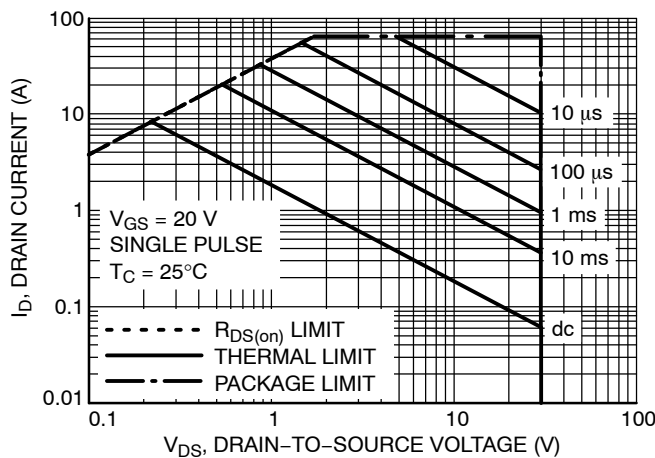


Figure 11. Maximum Rated Forward Biased Safe Operating Area

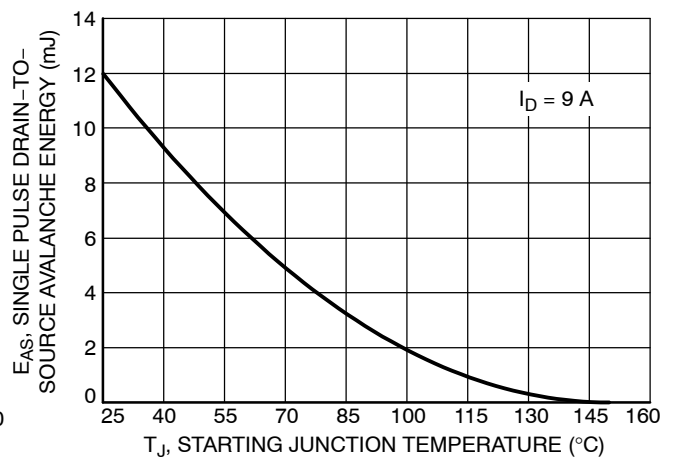


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

NTLLD4901NF

TYPICAL CHARACTERISTICS – Q1

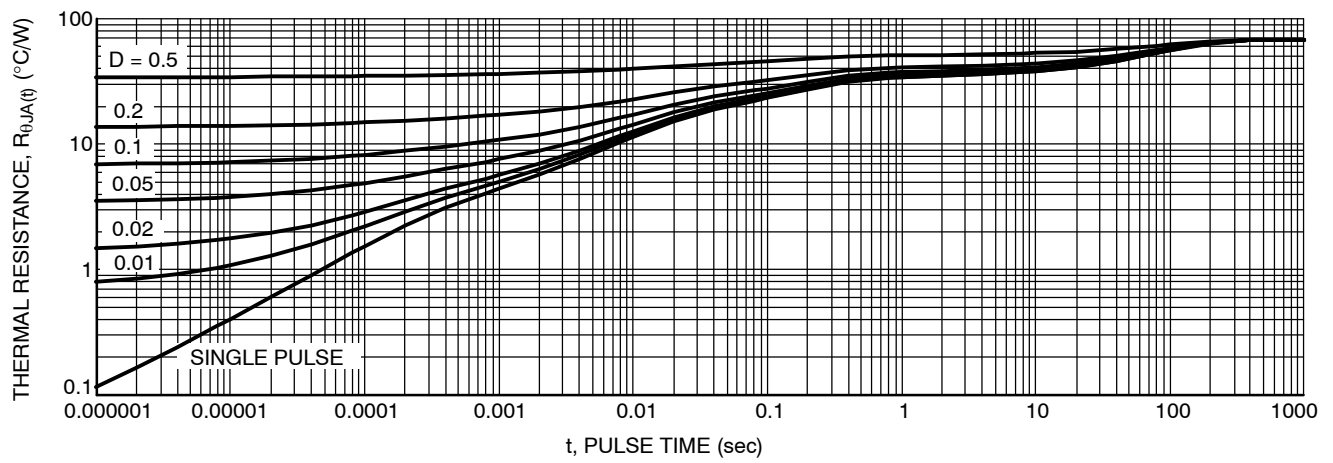


Figure 13. Thermal Response

TYPICAL CHARACTERISTICS – Q2

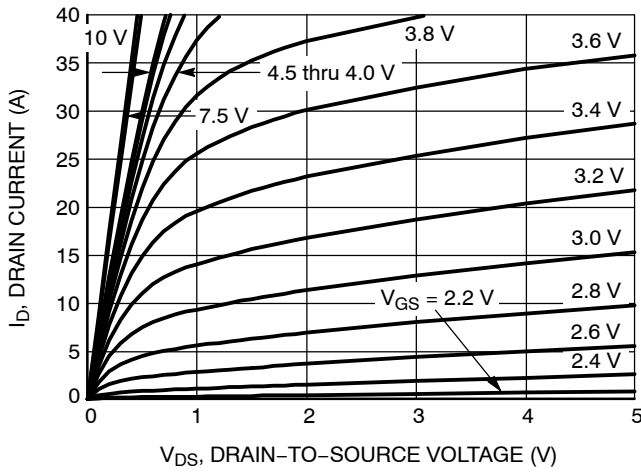


Figure 14. On-Region Characteristics

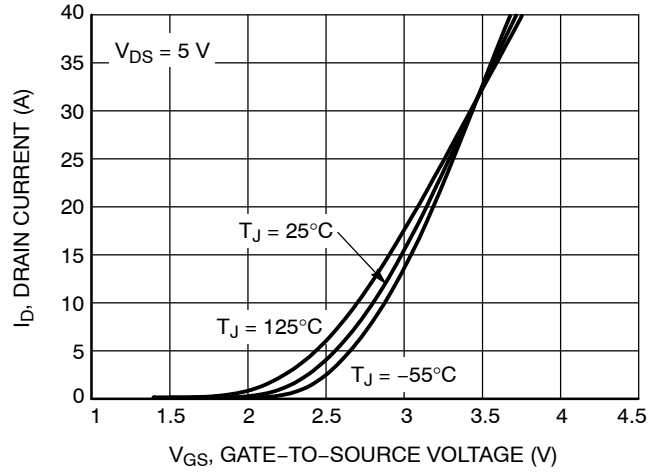


Figure 15. Transfer Characteristics

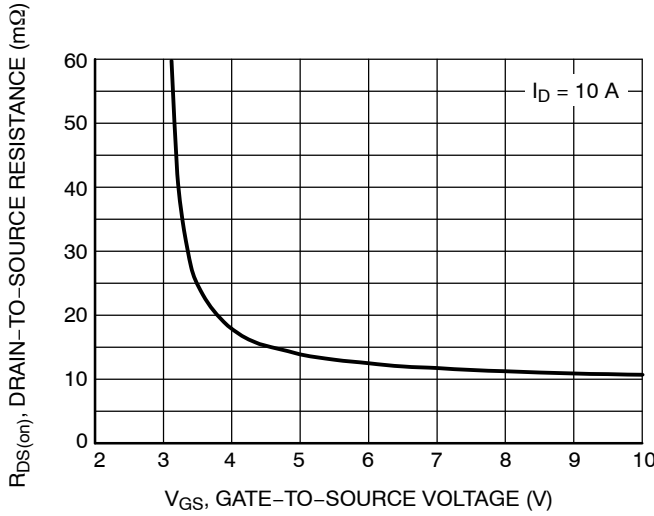


Figure 16. On-Resistance vs. Gate-to-Source Resistance

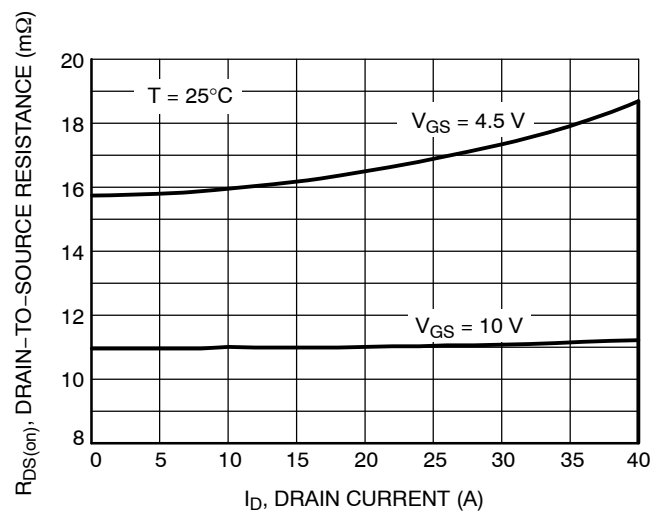


Figure 17. On-Resistance vs. Drain Current and Gate Voltage

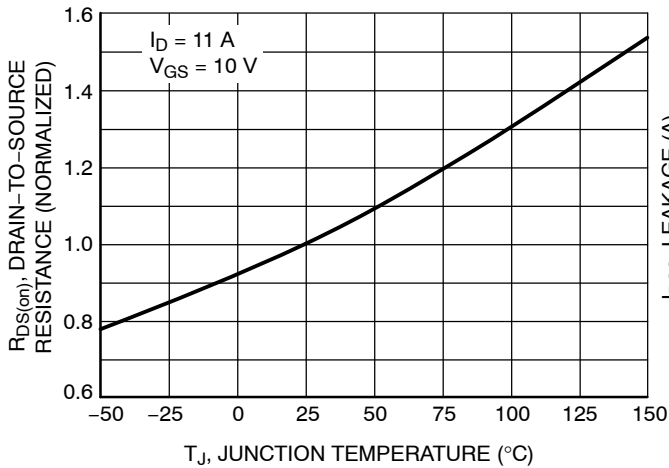


Figure 18. On-Resistance Variation with Temperature

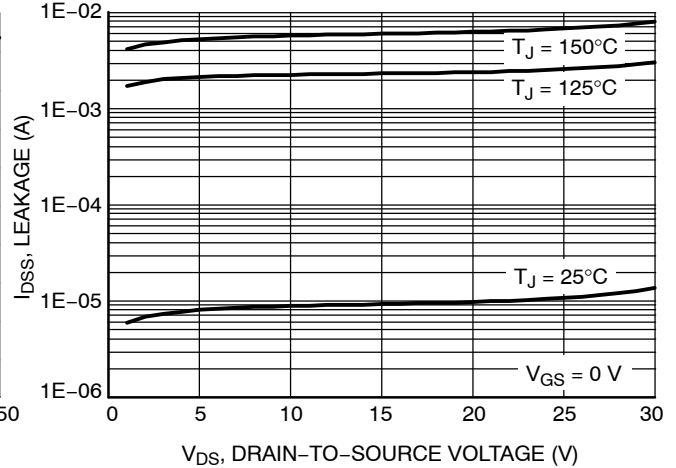


Figure 19. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS – Q2

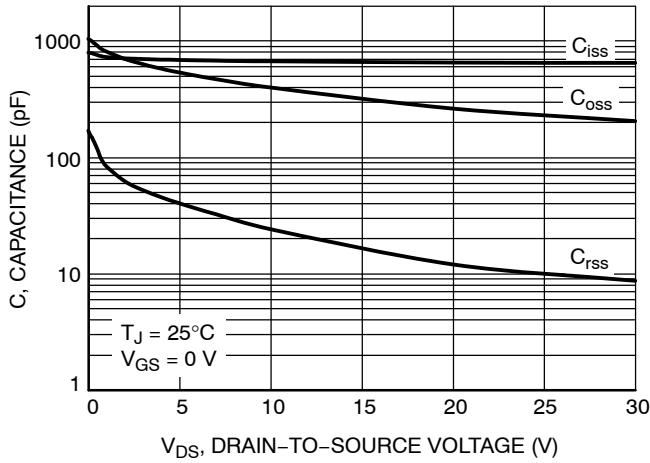


Figure 20. Capacitance Variation

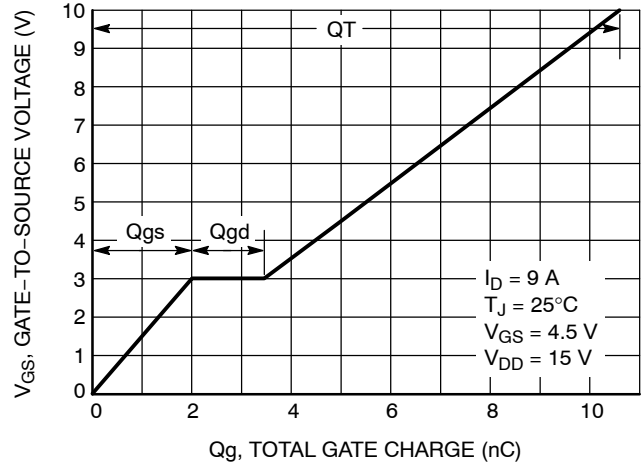


Figure 21. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

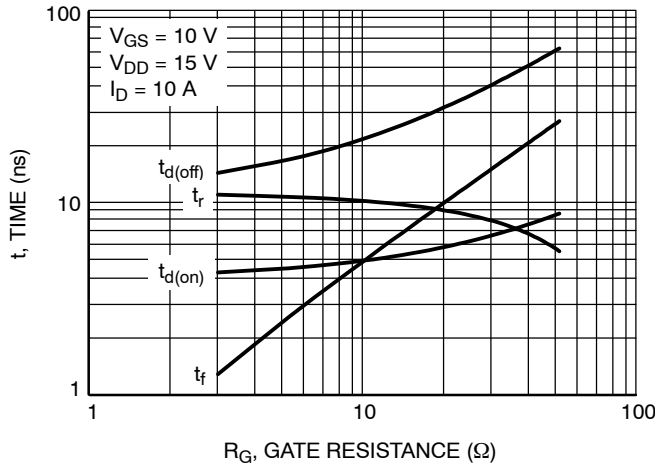


Figure 22. Resistive Switching Time Variation vs. Gate Resistance

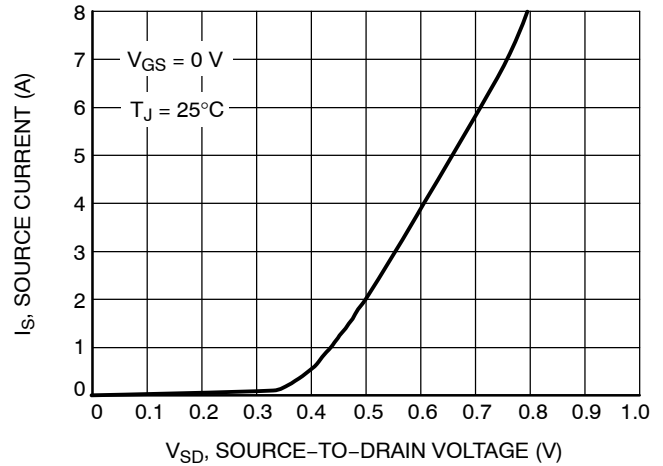


Figure 23. Diode Forward Voltage vs. Current

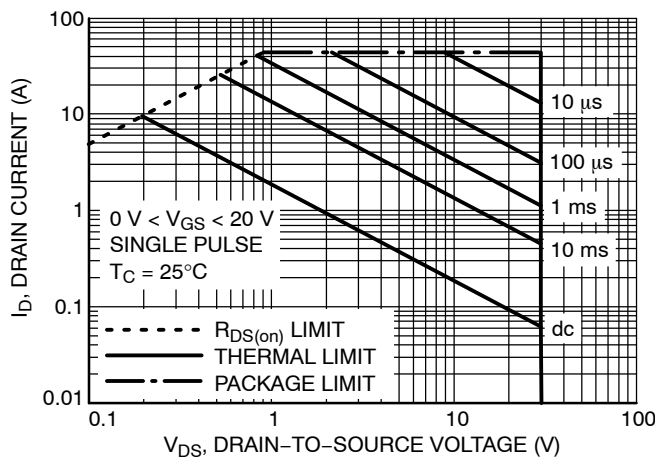


Figure 24. Maximum Rated Forward Biased Safe Operating Area

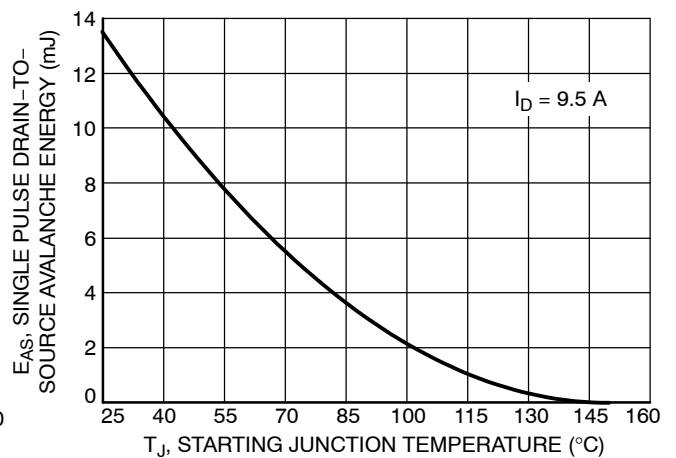


Figure 25. Maximum Avalanche Energy vs. Starting Junction Temperature

NTLLD4901NF

TYPICAL CHARACTERISTICS – Q2

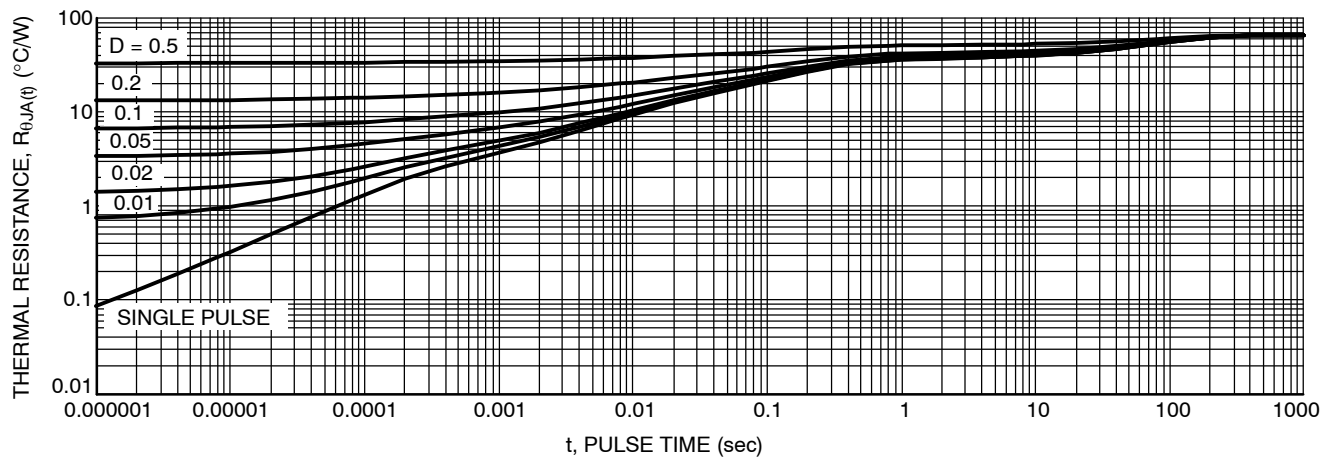


Figure 26. Thermal Response



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

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